TITLE: MULTIFUNCTION 12GB/S (SAS/PCIE) CONNECTOR

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2 SCOPE

This specification covers performance, tests and quality requirements for MULTIFUNCTION 16GB/S (SAS/PCIE) Connector

3 APPLICABLE DOCUMENTS

EIA-364: ELECTRONICS INDUSTRIES ASSOCIATION TS-1000: ENVIRONMENTAL TEST METHODOLOGY

SFF-8639: SFF SPECIFICATION

4 REQUIREMENTS

- 4.1 Design and Construction
 - 4.1.1 Product shall be of design, construction and physical dimensions specified on applicable product drawing.
 - 4.1.2 All materials conform to R.o.H.S. and the standard depends on TQ-WI-140101.
- 4.2 Materials and Finish
 - 4.2.1 Contact: High performance copper alloy (Phosphor Bronze)

Finish: (a) Contact Area: Refer to the drawing.

- (b) Under plate: Refer to the drawing.
- (c) Solder area: Refer to the drawing.
- 4.2.2 Housing: Thermoplastic or Thermoplastic High Temp., UL94V-0
- 4.2.3 CAP: Thermoplastic or Thermoplastic High Temp., UL94V-0
- 4.2.4 Fit Nail: High performance alloy(Brass or Stainless steel)

Finish: (a) Under plate: Refer to the drawing.

(b) Solder area: Refer to the drawing.

4.3 Ratings

- 4.3.1 Working Voltage Less than 30 Volts AC (per pin)
- 4.3.2 Voltage: 30 Volts AC (per pin)
- 4.3.3 Current: 1.5 Amperes (per pin)
- 4.3.4 Operating Temperature : 0°C to +55°C
- 4.3.5 Non-Operating Temperature : -40° to +85° €
- 4.4 Mates
 - 4.4.1 This receptacle conn. is mates with SFF-8639 plug side.

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5 Performance

5.1. Test Requirements and Procedures Summary

Item	Requirement	Standard				
Examination of Product	Product shall meet requirements of	Visual, dimensional and functional				
	applicable product drawing and	per applicable quality inspection				
	specification.	plan.				
ELECTRICAL						
Item	Requirement	Standard				
	Initial: 30 mΩ Max.	Mate connectors, measure by dry				
Low Level	After test: $15 \text{ m}\Omega$ Max. change	circuit, 20mV Max., 100mA				
Contact Resistance	allowed	Max.				
	anowed	(EIA-364-23)				
		Unmated connectors, apply				
Insulation Resistance	1000 MΩ Min.	500 V DC between adjacent				
Insulation resistance	1000 10122 101111.	terminals.				
		(EIA-364-21)				
		500 V AC Min. at sea level for 1				
Dielectric	No discharge, flashover or	minute.				
Withstanding Voltage	breakdown.	Test between adjacent contacts of				
Translanding reliage	Current leakage: 1 mA max.	unmated connectors.				
		(EIA-364-20)				
		Wire contact pins P1,P2,P8 and P9				
		in parallel for power				
Temperature Rise		Wire contact pins P4,P5,P6,P10 and				
		P12 in parallel for return				
		Supply 6 Amp total DC current to				
	00%	the power pins in parallel,returning				
	30℃ Max. Change allowed	from the parallel ground pins				
		Measure and record the				
		temperature after 96 hours(45				
		minutes ON and 15minutes OFF per				
		hours) in ambient condition of 25°C				
		still air				
		(EIA-364-70,Method2)				

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MECHANICAL					
Item	Requirement	Standard			
Durability	500 Cycles for Backplane Receptacle After test: 15 mΩ Max. change allowed	The sample should be mounted in the tester and fully mated and unmated the number of cycles. (EIA-364-09)			
Durability(precondition)	Perform 50 mate/unmate cycles if the application requires 500 cycles.	No evidence of physical damage (EIA-364-09)			
Mating Un-mating Force	Mating Force: 59N Max. Un-mating Force: 6N Min.	Measure the force required to mate/unmate connector. (EIA-364-13 Method A)			
Contact & Fit Nail Retention	Retention Force: 2N Min.	Measure the retention force of contact and Fit Nail in the housing.			
Vibration	No discontinuity longer than 1 microsecond allowed. 15 mΩ Max. change from initial contact resistance.	Subject mated specimens to 3.10G's rms between 20-500 Hz for 15 minutes in each of 3 mutually perpendicular planes. (EIA-364-28 Condition VII)			
Mechanical Shock	No discontinuity longer than 1 microsecond allowed. 15 mΩ Max. change from initial contact resistance.	Subject mated specimens to 50G's half-sine shook pulses of 11milliseconds duration 3 shocks in each direction applied along 3 mutually perpendicular planes, 18 total shocks. (EIA-364-27)			
Resistance to Reflow Soldering Heat	No discharge	Pre Heat: 150°C ~180°C, 60~120sec. Heat: 230°C Min., 40sec Min. Peak Temp.: 260°C Max, 10sec Max.			
Reseating	Appearance: No damage	Manually mated/unmated the connector or socket perform 3 cycles.			

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ENVIRONMENTAL					
Item	Requirement	Standard			
Thermal Shock	See Product Qualification and Test Sequence Group 5	Mate module and subject to follow condition for 10 cycles. 1 cycles: -55°C and +85°C each 30min. (EIA-364-32,Test condition I)			
Temperature Life	See Product Qualification and Test Sequence Group 3	Subject mated connectors to temperature life at 85°C for 500 hours. (EIA-364-17, Test condition III ,method A, Test time condition C)			
Temperature Life (precondition)	No physical damage	Subject mated connectors to temperature life at 105°C for 72 hours. (EIA-364-17, method A)			
Salt Spray	See Product Qualification and Test Sequence Group 1	Subject mated connectors to 5%			
Humidity	No Physical damege Initial: $30~\text{m}\Omega$ Max. After test: $15~\text{m}\Omega$ Max. change allowed	Subject mated connectors to temperature and humidity of 40°C with 90% to 95% RH for 96 hours. (EIA-364-31 Method II Test Condition A)			
Solder Ability	minimum of 95% solder coverage. Gold plating:	Add then into solder bath, Temperature at 245 ±5°C, for 4-5 sec. (EIA-364-52)			

Note. Flowing Mixed Gas shall be conduct by customer request.

	Aces P/N: 52961 SERIES
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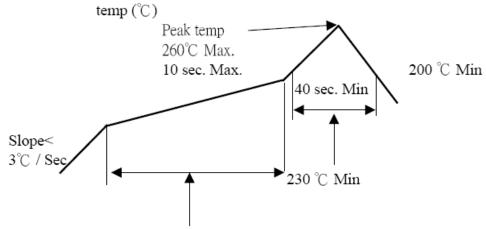
6 INFRARED REFLOW CONDITION

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TEMPERATURE CONDITION GRAPH (TEMPERATURE ON BOARD PATTERN SIDE)

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Pre-heat Hold time for $150 \sim 180$ °C is $60 \sim 120$ sec.

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7 PRODUCT QUALIFICATION AND TEST SEQUENCE

	Test Group							
Test or Examination	1	2	3	4	5	6	7	8
	Test Sequence							
Examination of Product	1 \ 5 8	1 · 6 10	1 \ 5 8 \ 11	1 ` 6	1 · 8 11 · 14	1 . 7	1 \ 3	1 \ 4
Low Level Contact Resistance	2 · 4 7	2 · 5 9	2 · 4 7 · 10		2 · 7 10 · 13	3 ` 6		
Insulation Resistance					3、15			
Dielectric Withstanding Voltage					4、16			
Temperature Rise				5				
Durability	3					4		
Durability(precondition)		3	3	2	5			
Mating / Unmating Forces						2 ` 5		
Contact & Fit Nail Retention								3
Vibration		7						
Mechanical Shock		8						
Resistance to Reflow Soldering Heat								2
Reseating			9	4	12			
Thermal Shock					6			
Temperature Life			6	3				
Temperature Life(precondition)		4						
Salt Spray	6							
Humidity					9			
Solder Ability							2	
Sample Size	4	4	4	4	4	4	4	4